NI USB-5681 RF Power Meter Specifications

This document lists specifications for the NI USB-5681 RF power meter. Minimum or maximum specifications are warranted under the following conditions:

- 1 hour warm-up time at ambient temperature
- Calibration cycle maintained
- Temperature 0 °C to 50 °C unless otherwise noted

Typical values are used to define a non-warranty specification that at least 68% of units exhibit at ambient temperatures of 15 °C to 35 °C. Specifications that do not list tolerance values are typical values unless otherwise specified. Tolerance values represent the maximum variation.

Specifications subject to change without notice. For the most recent NI 5681 specifications, visit ni.com/manuals.

General

Frequency range	10 MHz to 18 GHz
Input range	40 dBm to +20 dBm
Input return loss	
10 MHz to <150 MHz	>22.12 dB
150 MHz to 2 GHz	>24.94 dB
>2 GHz to 12 GHz	>20.08 dB
>12 GHz to 18 GHz	>19.08 dB



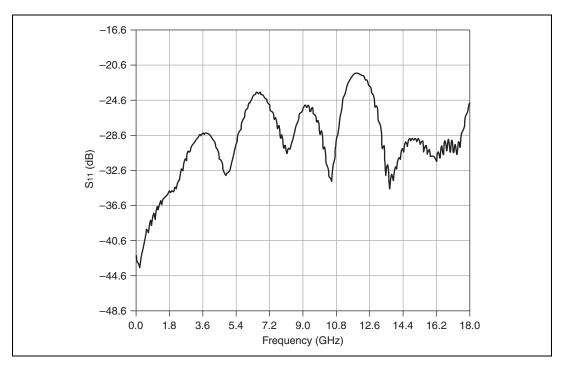


Figure 1. Power Meter Return Loss, Measured

Measurement range
Range 1+20 dBm to -7 dBm, typical
Range 2-7 dBm to -40 dBm, typical
Signal-channel bandwidth50 kHz

Uncertainty

Linearity<3% (±0.13 dB)
Calibration factor ¹
10 MHz<2.3% (±0.10 dB)
50 MHz to 18 GHz<1.5% (±0.07 dB)
Noise ²
Measurement range 1<8 μ W (-21 dBm)
Measurement range 2<40 nW (-44 dBm)

Expanded uncertainty with coverage factor K = 2 for absolute power measurements on a continuous wave (CW) signal at 0 dBm and calibration frequencies 10 MHz, 50 MHz, 100 MHz, 300 MHz, 500 MHz, and 1 GHz to 18 GHz, in 1 GHz increments.

² Expanded uncertainty with K = 2 after zero operation when measured with 1 average, and 20 ms aperture time for 5 minutes. Effect of noise can be reduced by increasing the number of averages and/or increasing the aperture time. Noise decreases at a rate equal to the square root of the number of averages and aperture time.

Zero set ¹
Measurement range 1<1 μW
Measurement range 2<3 nW
Zero drift ²
Measurement range 1<0.5 μW
Measurement range 2<3 nW
Temperature compensation
0 °C to 50 °C<1.4% ($\pm 0.06 \text{ dB}$)
Effect of digital modulation ³
Power level ≥18 dBm<1.4% (±0.06 dB)
Power level <18 dBm<0.5% (±0.02 dB)

System

Measurement
Measurement resolution ⁴ 0.01 dB
Offset range100 dB to +150 dB
AveragingAuto, repeat
Number of averages (repeat) ⁵ 1 to 40,000
Auto-averaging
Resolution ⁶ 1 dB, 0.1 dB, 0.01 dB, 0.001 dB
Source Time Slot mode: 1 to 128 slots
Scope mode: 1 to 1,024 data
points

 $^{^{1}}$ Expanded uncertainty with K=2 after zero operation when measured with 1 average and 20 ms aperture time for 5 minutes.

² Expanded uncertainty with K = 2 after one hour warm-up and zero operation and one hour of operation, 1 average, 20 ms aperture time, and when keeping the temperature within ± 1 °C.

³ Measurement error with reference to a CW signal of equal power and frequency at 25 °C.

⁴ Resolution in the NI-568x Soft Front Panel (SFP) is two digits after the decimal. Native resolution of the sensor is three digits after the decimal.

Maximum number of averages allowed in Continuous mode and Time Slot mode is 40,000. In Scope mode, the maximum number of averages is equal to 8,231,936 divided by data points.

⁶ Averaging resolution of 0.001 dB is not available with the NI-568x SFP. This feature is only available when using the NI-568x instrument driver. Averaging resolution is defined as the place after the decimal to which the reading becomes stable.

Continuous Mode

Duty cycle correction	0.01% to 100%
Aperture time	.0.01 ms to 300 ms
Measurement time ¹	.(Number of Averages \times a) + b, where a and b depend on the aperature time, as shown in the following table.

Aperture Time (ms)	a (ms)	b (ms)
0.01	2	6.5
0.1	2.3	6.5
1	5.4	7.1
10	35.8	20.5
100	331	164

Scope Mode

Capture time	0.01 ms to 300 ms
Data points	1 to 1,024
Resolution	0.01 ms
Measurement time ²	(Capture Time in $ms \times 6.69$) + (Data Points $\times 0.36$ ms) + 13.6 ms

Time Slot Mode

Maximum number of slots	128
Slot width	0.01 ms to 100 ms
Maximum capture time	300 ms (Slot Width \times Number of Slots)

 $^{^{\}rm 1}\,$ Times based on benchmark results. Performance may vary based on your system.

² Times based on benchmark results. Performance may vary based on your system. Formula assumes averaging is set to 1, and trigger source is set to Immediate.

Resolution	0.01 ms
Exclusion periods ¹	
Start exclusion	0 ms to 100 ms
End exclusion	0 ms to 100 ms

Trigger

Source² Immediate, external, internal, software

Internal Trigger

External Trigger

 Impedance
 $100 \text{ k}\Omega$

 Type
 TTL/CMOS

 Slope
 Positive or negative

 Delay range
 -5 ms to 10 s

 Delay resolution
 10 μs

 Voltage high threshold
 2.0 V, typical

 Voltage low threshold
 1.2 V, typical

 Hysteresis
 0.8 V, typical

 Maximum voltage
 $\pm 20 \text{ V}$

 Minimum pulse width
 7.5 μs^3

¹ The start exclusion time plus the end exclusion time must be less than the slot width.

² Software trigger not available in the NI-568x SFP. This feature is only available when using the NI-568x instrument driver. Internal and external triggers are not available when using Continuous acquisition mode.

 $^{^{3}}$ The external trigger source is sampled approximately every 7.5 μ s.

Maximum Damage Levels

Maximum DC voltage at RF port.....±20 V
Absolute power.....+30 dBm

DC Power Requirements (5V) through Host USB

Typical current......150 mA

Calibration

Physical Dimensions

Environment

Operating Environment

Ambient temperature range0 °C to 50 °C (Tested in accordance with MIL-PRF-28800F (Class 3).)

Relative humidity range² (noncondensing)

¹ Tests were performed per MIL-PRF-28800F (Class 2).

² Tested in accordance with MIL-PRF-28800F (Class 3).

Storage Environment

Ambient temperature range	–40 °C to +71 °C
	(Tested in accordance with
	MIL-PRF-28800F (Class 3).)
Relative humidity range	5% to 95%, noncondensing
	(Tested in accordance with
	MIL-PRF-28800F (Class 3).)

Shock and Vibration

Nonoperational shock	
Random vibration	
nonoperating	10 Hz to 500 Hz, Power spectral
	density 0.03 g ² /Hz
	(Tested in accordance with

MIL-PRF-28800F.)

Compliance and Certifications

Safety

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

• EN 61010-1



Note For UL and other safety certifications, refer to the product label or the *Online Product Certification* section.

Electromagnetic Compatibility

This product is designed to meet the requirements of the following standards of EMC for electrical equipment for measurement, control, and laboratory use:

- EN 61326 EMC requirements; Minimum Immunity
- EN 5501 Emissions; Group 1, Class A
- EN 61000-4-2/3/4/5/6/11 Immunity
- CE, C-Tick, and FCC Part 15 Emissions; Class A



Note For EMC compliance, operate this device according to product documentation.

CE Compliance $\subset \in$

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

- 2006/95/EC; Low-Voltage Directive (safety)
- 2004/108/EC; Electromagnetic Compatibility Directive (EMC)

Online Product Certification

To obtain product certifications and the Declaration of Conformity for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Environmental Management

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For additional environmental information, refer to the *NI and the Environment* Web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

Waste Electrical and Electronic Equipment (WEEE)



EU Customers At the end of the product life cycle, all products *must* be sent to a WEEE recycling center. For more information about WEEE recycling centers, National Instruments WEEE initiatives, and compliance with WEEE Directive 2002/96/EC on Waste and Electronic Equipment, visit ni.com/environment/weee.

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